

**Notice of References Cited**

Application/Control No.

09/831,061

Applicant(s)/Patent Under  
Reexamination  
BONNEFOY ET AL.

Examiner

S. Devi, Ph.D.

Art Unit

1645

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0014661 A1	01-2004	Goetsch et al.	514/12
*	B	US-2004/0014207 A1	01-2004	Pease et al.	435/345
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	English translation of Andreoni et al. WO 99/49892.
	V	English translation of Binz et al. WO 97/41888.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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SD  
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